

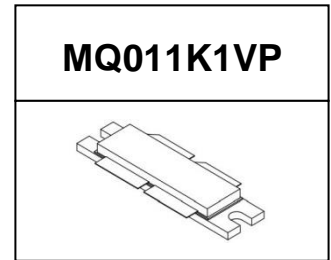
MQ011K1VP LDMOS TRANSISTOR

Document Number: MQ011K1VP
Preliminary Datasheet V1.0

1100W, 50V High Power RF LDMOS FETs

Description

The MQ011K1VP is a 1100-watt, unmatched LDMOS FETs, designed for Aerospace and Air Navigation System applications with frequencies from HF to 0.2GHz.



Features

- High Efficiency and Linear Gain Operations
- Integrated ESD Protection
- Internally Matched for Ease of Use
- Large Positive and Negative Gate/Source Voltage Range for Improved Class C Operation
- Excellent thermal stability, low HCI drift
- Compliant to Restriction of Hazardous Substances (RoHS) Directive 2002/95/EC

Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain--Source Voltage	V_{DSS}	125	Vdc
Gate--Source Voltage	V_{GS}	-10 to +10	Vdc
Operating Voltage	V_{DD}	+55	Vdc
Storage Temperature Range	T_{stg}	-65 to +150	°C
Case Operating Temperature	T_c	+150	°C
Operating Junction Temperature	T_j	+225	°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction to Case, Case Temperature 80°C, 1000W Pulse CW, 50 Vdc, $I_{DQ} = 100$ mA	$R_{\theta JC}$	TBD	°C/W

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22--A114)	Class 2

Table 4. Electrical Characteristics (TA = 25 °C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
DC Characteristics					
Drain-Source Voltage $V_{GS}=0, I_{DS}=1.0$ mA	$V_{(BR)DSS}$		129		V
Zero Gate Voltage Drain Leakage Current ($V_{DS} = 50$ V, $V_{GS} = 0$ V)	I_{DSS}	—	—	1	μA
Gate—Source Leakage Current ($V_{GS} = 10$ V, $V_{DS} = 0$ V)	I_{GSS}	—	—	1	μA

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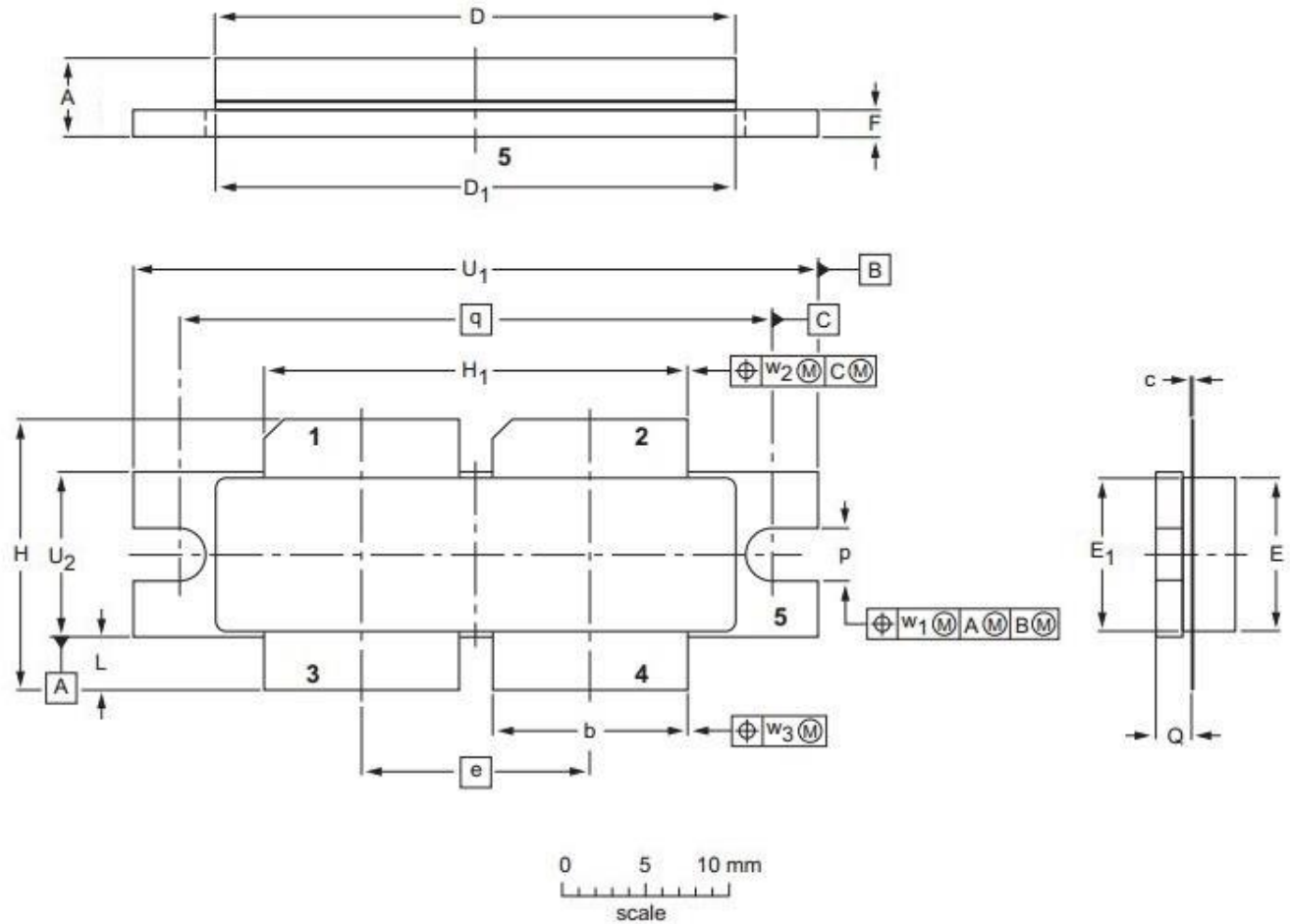
Gate Threshold Voltage ($V_{DS} = 50V$, $I_D = 600 \mu A$)	$V_{GS(th)}$	—	2.54	—	V
Gate Quiescent Voltage ($V_{DD} = 50V$, $I_D = 400mA$, Measured in Functional Test)	$V_{GS(Q)}$	—	3.1	—	V
Drain source on state resistance ($V_{DS} = 0.1V$, $V_{GS} = 10V$) Each section side of device measured	$R_{ds(on)}$		108		m Ω
Common Source Input Capacitance ($V_{GS} = 0V$, $V_{DS} = 50V$, $f = 1MHz$) Each section side of device measured	C_{ISS}		430		pF
Common Source Output Capacitance ($V_{GS} = 0V$, $V_{DS} = 50V$, $f = 1MHz$) Each section side of device measured	C_{OSS}		100.7		pF
Common Source Feedback Capacitance ($V_{GS} = 0V$, $V_{DS} = 50V$, $f = 1MHz$) Each section side of device measured	C_{RSS}		1.59		pF

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Package Outline

Flanged ceramic package; 2 mounting holes; 4 leads (1、2—DRAIN、3、4—GATE、5—SOURCE)



UNIT	A	b	c	D	D ₁	e	E	E ₁	F	H	H ₁	L	p	Q	q	U ₁	U ₂	W ₁	W ₂	W ₂
mm	4.7	11.81	0.18	31.55	31.52	13.72	9.50	9.53	1.75	17.12	25.53	3.48	3.30	2.26	35.56	41.28	10.29	0.25	0.51	0.25
	4.2	11.56	0.10	30.94	30.96		9.30	9.27	1.50	16.10	25.27	2.97	3.05	2.01		41.02	10.03			
inches	0.185	0.465	0.007	1.242	1.241	0.540	0.374	0.375	0.069	0.674	1.005	0.137	0.130	0.089	1.400	1.625	0.405	0.01	0.02	0.01
	0.165	0.455	0.004	1.218	1.219		0.366	0.365	0.059	0.634	0.995	0.117	0.120	0.079		1.615	0.395			

OUTLINE VERSION	REFERENCE			EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA		
PKG-D4E					03/12/2013

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Revision history

Table 6. Document revision history

Date	Revision	Datasheet Status
2017/07/31	Rev 1.0	Preliminary Datasheet

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